

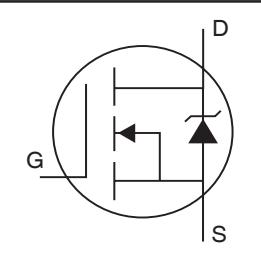
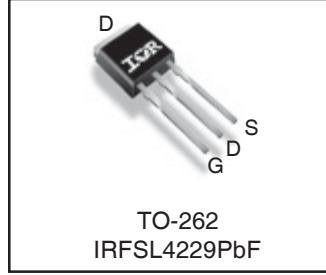
# IRFSL4229PbF

## Features

- Advanced Process Technology
- Low  $Q_G$  for Fast Response
- High Repetitive Peak Current Capability for Reliable Operation
- Short Fall & Rise Times for Fast Switching
- 175°C Operating Junction Temperature for Improved Ruggedness
- Repetitive Avalanche Capability for Robustness and Reliability

Key Parameters		
$V_{DS}$ min	250	V
$V_{DS}$ (Avalanche) typ.	300	V
$R_{DS(ON)}$ typ. @ 10V	42	$m\Omega$
$I_{RP}$ max @ $T_C = 100^\circ C$	91	A
$T_J$ max	175	$^\circ C$

		
<b>TO-262</b> IRFSL4229PbF		
<b>G</b> Gate	<b>D</b> Drain	<b>S</b> Source

## Description

This HEXFET® Power MOSFET utilizes the latest processing techniques to achieve low on-resistance per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device.

## Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{GS}$	Gate-to-Source Voltage	$\pm 30$	V
$I_D$ @ $T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	45	A
$I_D$ @ $T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	32	
$I_{DM}$	Pulsed Drain Current ①	180	
$I_{RP}$ @ $T_C = 100^\circ C$	Repetitive Peak Current ②	91	
$P_D$ @ $T_C = 25^\circ C$	Power Dissipation	330	W
$P_D$ @ $T_C = 100^\circ C$	Power Dissipation	190	
	Linear Derating Factor	2.2	W/ $^\circ C$
$T_J$	Operating Junction and	$-40$ to $+175$	$^\circ C$
$T_{STG}$	Storage Temperature Range		
	Soldering Temperature for 10 seconds	300	
	Mounting Torque, 6-32 or M3 Screw	10lb·in (1.1N·m)	

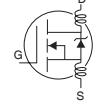
## Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ④	—	0.45*	
$R_{\theta JA}$	Junction-to-Ambient ④	—	62	

\*  $R_{\theta JC}$  (end of life) for TO-262 =  $0.65^\circ C/W$ . This is the maximum measured value after 1000 temperature cycles from  $-55$  to  $150^\circ C$  and is accounted for by the physical wearout of the die attach medium.

Notes ① through ⑤ are on page 8

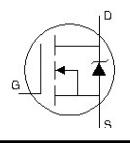
Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

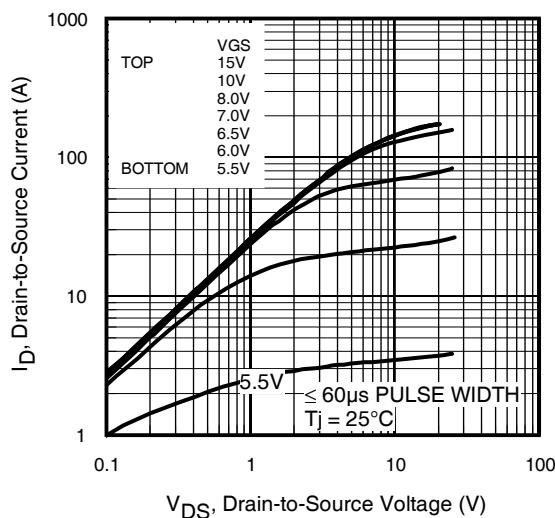
	Parameter	Min.	Typ.	Max.	Units	Conditions
$\text{BV}_{\text{DSS}}$	Drain-to-Source Breakdown Voltage	250	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	210	—	mV/°C	Reference to $25^\circ\text{C}$ , $\text{I}_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	42	48	$\text{m}\Omega$	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 26\text{A}$ ③
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	3.0	—	5.0	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$
$\Delta \text{V}_{\text{GS}(\text{th})}/\Delta T_J$	Gate Threshold Voltage Coefficient	—	-14	—	mV/°C	
$\text{I}_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$\text{V}_{\text{DS}} = 250\text{V}, \text{V}_{\text{GS}} = 0\text{V}$
		—	—	200		$\text{V}_{\text{DS}} = 250\text{V}, \text{V}_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$
$\text{I}_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	$\text{nA}$	$\text{V}_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$\text{V}_{\text{GS}} = -20\text{V}$
$\text{g}_{\text{fs}}$	Forward Transconductance	83	—	—	S	$\text{V}_{\text{DS}} = 25\text{V}, \text{I}_D = 26\text{A}$
$\text{Q}_g$	Total Gate Charge	—	72	110	$\text{nC}$	$\text{V}_{\text{DD}} = 125\text{V}, \text{I}_D = 26\text{A}, \text{V}_{\text{GS}} = 10\text{V}$ ③
$\text{Q}_{\text{gd}}$	Gate-to-Drain Charge	—	26	—		
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	18	—	$\text{ns}$	$\text{V}_{\text{DD}} = 125\text{V}, \text{V}_{\text{GS}} = 10\text{V}$ ③
$t_r$	Rise Time	—	31	—		$\text{I}_D = 26\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	30	—		$\text{R}_G = 2.4\Omega$
$t_f$	Fall Time	—	21	—		See Fig. 22
$t_{\text{st}}$	Shoot Through Blocking Time	100	—	—	ns	$\text{V}_{\text{DD}} = 200\text{V}, \text{V}_{\text{GS}} = 15\text{V}, \text{R}_G = 4.7\Omega$
$E_{\text{PULSE}}$	Energy per Pulse	—	790	—	$\mu\text{J}$	$\text{L} = 220\text{nH}, \text{C} = 0.3\mu\text{F}, \text{V}_{\text{GS}} = 15\text{V}$
		—	1390	—		$\text{V}_{\text{DS}} = 200\text{V}, \text{R}_G = 4.7\Omega, T_J = 25^\circ\text{C}$
$C_{\text{iss}}$	Input Capacitance	—	4560	—	$\text{pF}$	$\text{L} = 220\text{nH}, \text{C} = 0.3\mu\text{F}, \text{V}_{\text{GS}} = 15\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	390	—		$\text{V}_{\text{DS}} = 200\text{V}, \text{R}_G = 4.7\Omega, T_J = 100^\circ\text{C}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	100	—		
$C_{\text{oss eff.}}$	Effective Output Capacitance	—	290	—		$f = 1.0\text{MHz}, \text{V}_{\text{GS}} = 0\text{V}, \text{V}_{\text{DS}} = 0\text{V}$ to $200\text{V}$
$L_D$	Internal Drain Inductance	—	4.5	—	$\text{nH}$	Between lead, and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		

## Avalanche Characteristics

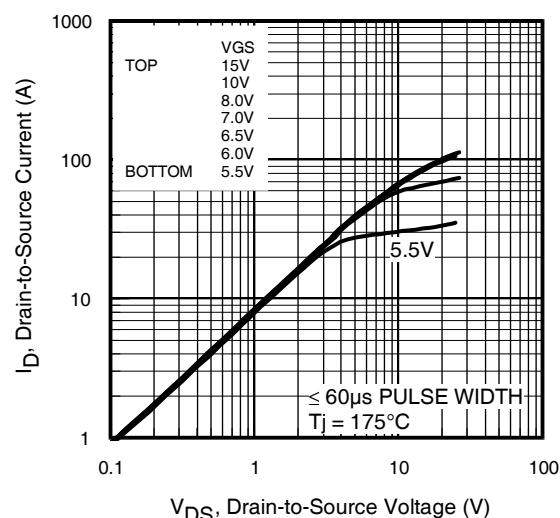
	Parameter	Typ.	Max.	Units
$E_{\text{AS}}$	Single Pulse Avalanche Energy ②	—	130	mJ
$E_{\text{AR}}$	Repetitive Avalanche Energy ①	—	33	mJ
$\text{V}_{\text{DS}(\text{Avalanche})}$	Repetitive Avalanche Voltage ①	300	—	V
$I_{\text{AS}}$	Avalanche Current ②	—	26	A

## Diode Characteristics

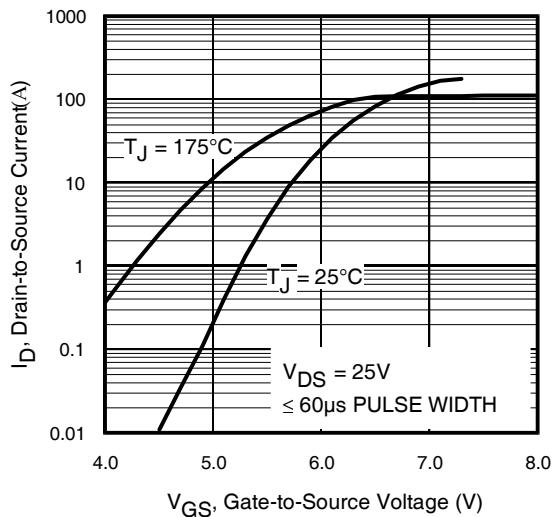
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S @ T_C = 25^\circ\text{C}$	Continuous Source Current (Body Diode)	—	—	45	$\text{A}$	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	180		
$\text{V}_{\text{SD}}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 26\text{A}, \text{V}_{\text{GS}} = 0\text{V}$ ③
$t_{\text{rr}}$	Reverse Recovery Time	—	190	290	ns	$T_J = 25^\circ\text{C}, I_F = 26\text{A}, \text{V}_{\text{DD}} = 50\text{V}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	840	1260	nC	$d\text{i}/dt = 100\text{A}/\mu\text{s}$ ③



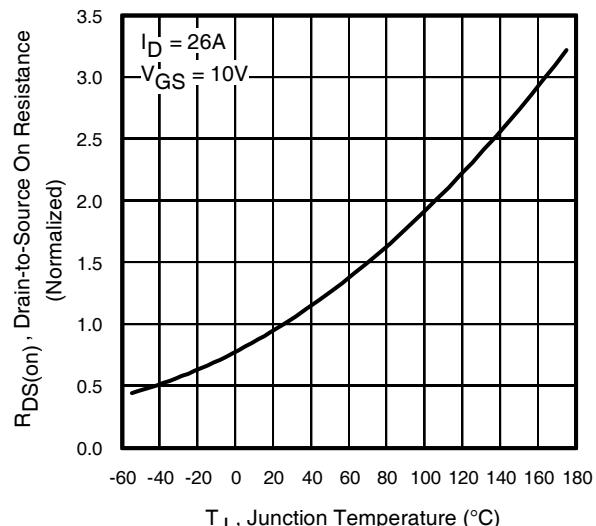
**Fig 1.** Typical Output Characteristics



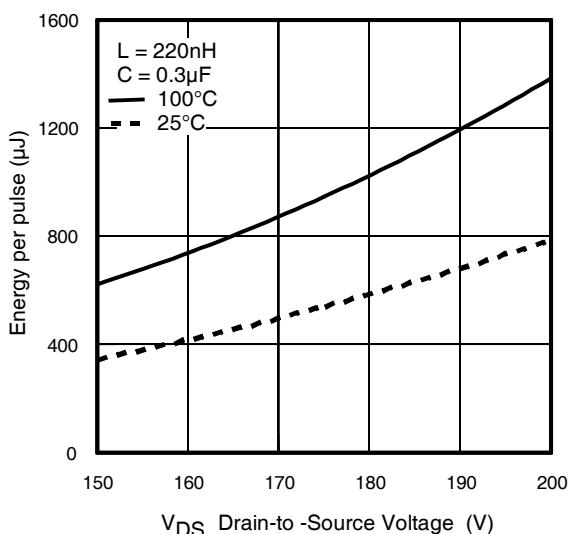
**Fig 2.** Typical Output Characteristics



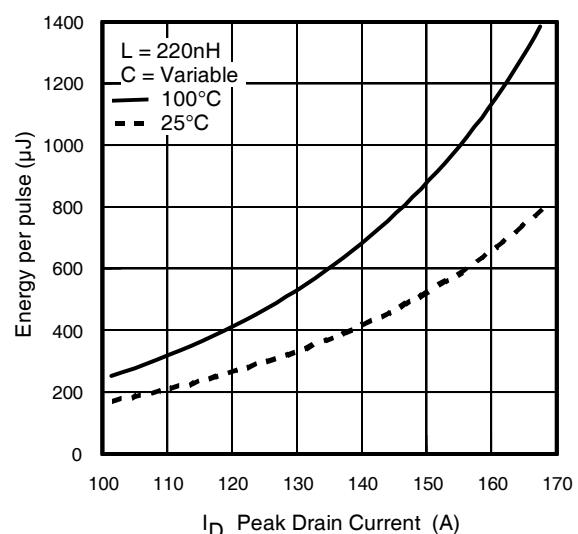
**Fig 3.** Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance vs. Temperature

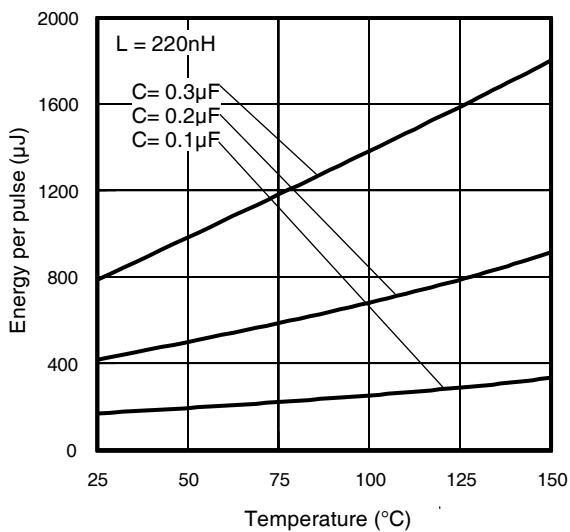


**Fig 5.** Typical  $E_{PULSE}$  vs. Drain-to-Source Voltage

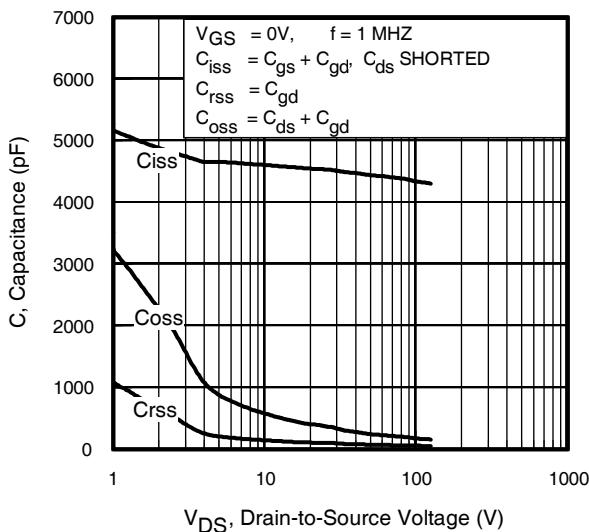


**Fig 6.** Typical  $E_{PULSE}$  vs. Drain Current

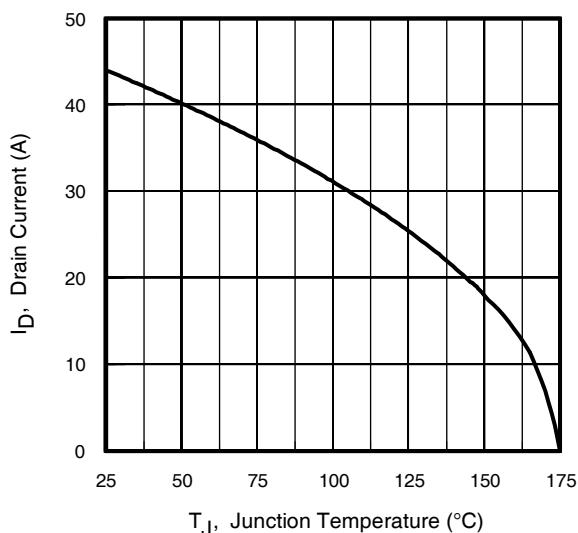
# IRFSL4229PbF



**Fig 7.** Typical  $E_{\text{PULSE}}$  vs.Temperature

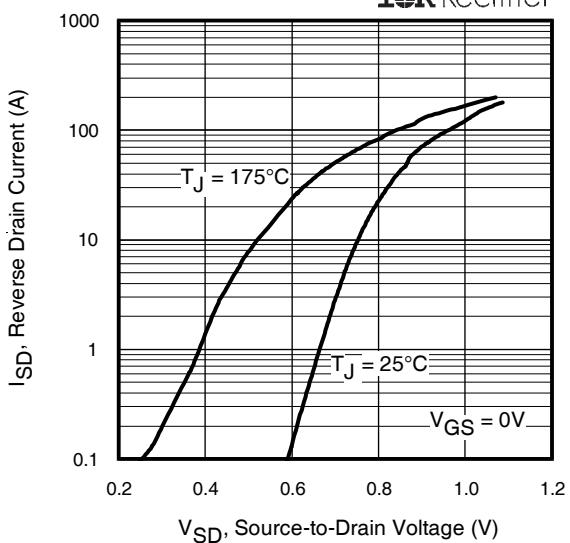


**Fig 9.** Typical Capacitance vs.Drain-to-Source Voltage

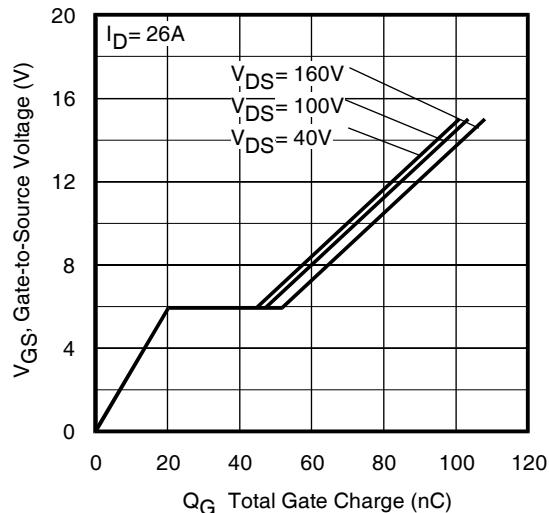


**Fig 11.** Maximum Drain Current vs. Case Temperature

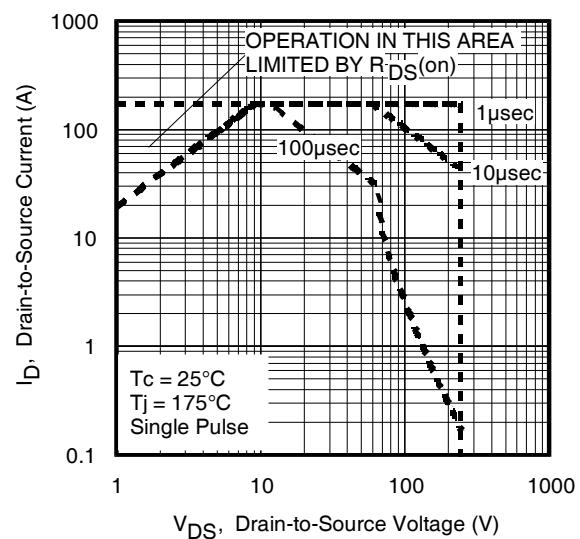
International  
Rectifier



**Fig 8.** Typical Source-Drain Diode Forward Voltage

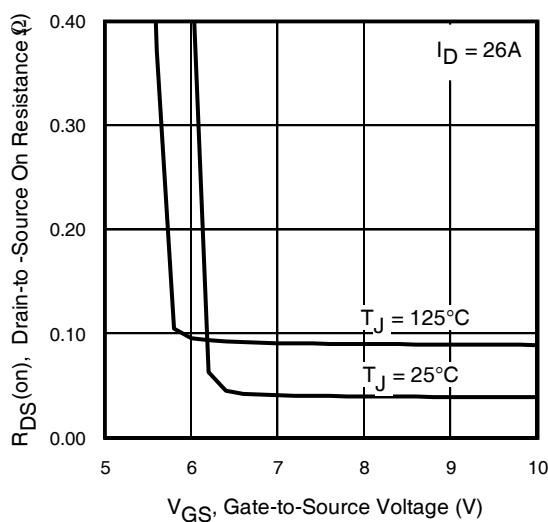


**Fig 10.** Typical Gate Charge vs.Gate-to-Source Voltage

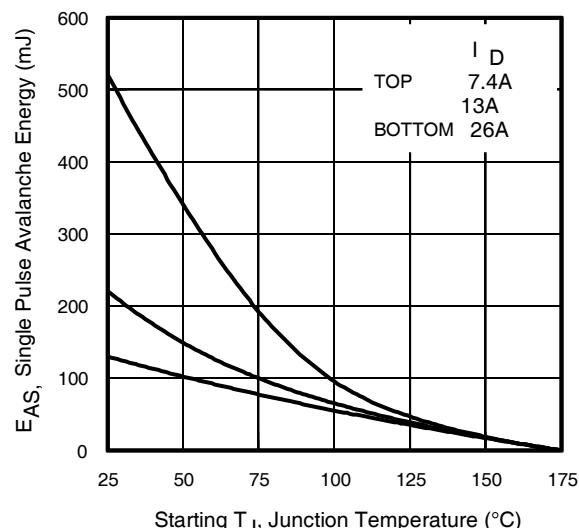


**Fig 12.** Maximum Safe Operating Area

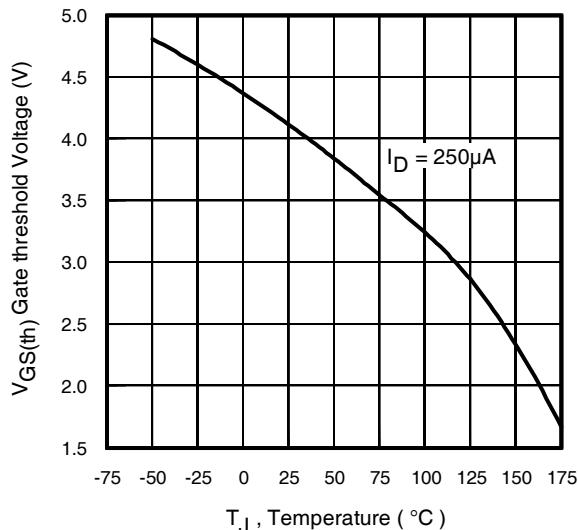
[www.irf.com](http://www.irf.com)



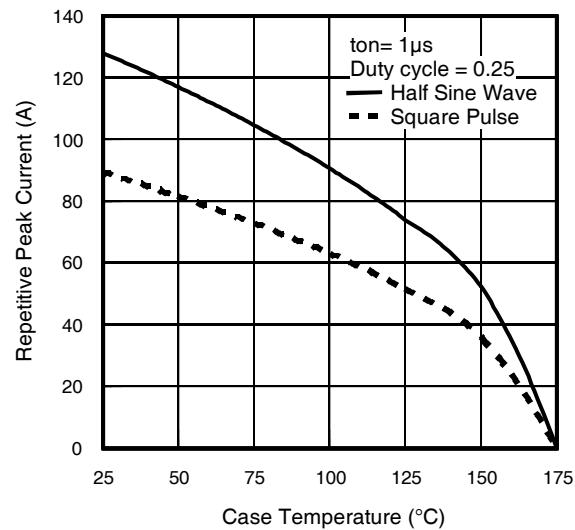
**Fig 13.** On-Resistance Vs. Gate Voltage



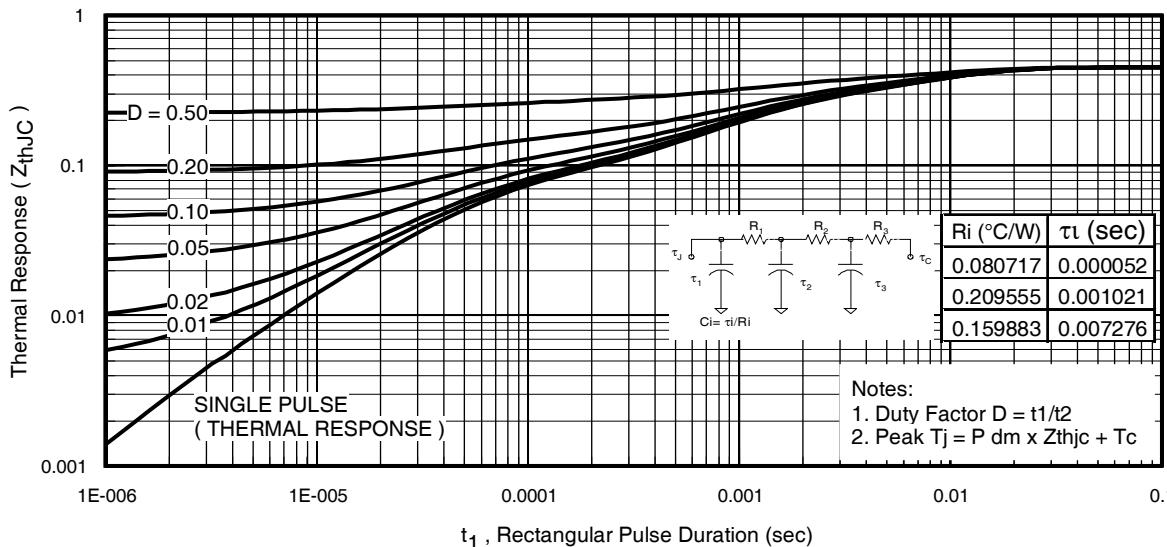
**Fig 14.** Maximum Avalanche Energy Vs. Temperature



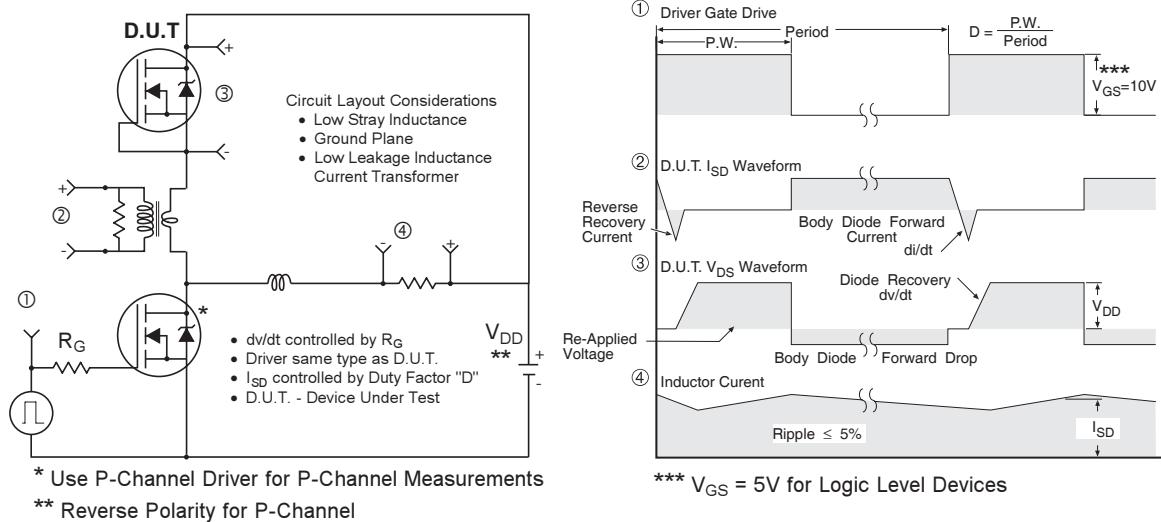
**Fig 15.** Threshold Voltage vs. Temperature



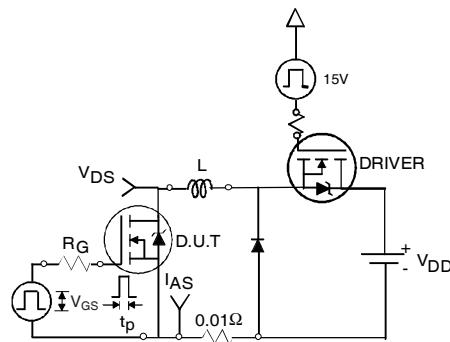
**Fig 16.** Typical Repetitive peak Current vs. Case temperature



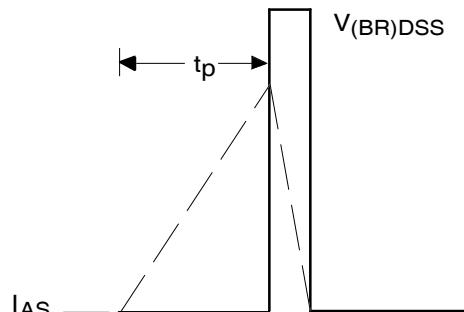
**Fig 17.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



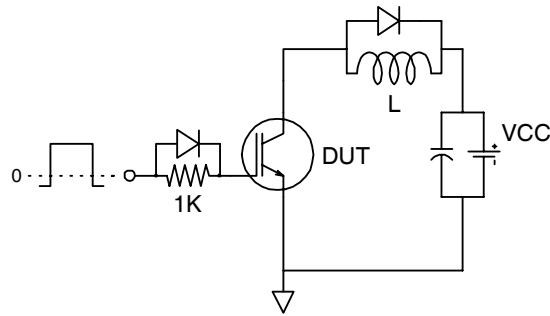
**Fig 18.** Diode Reverse Recovery Test Circuit for HEXFET® Power MOSFETs



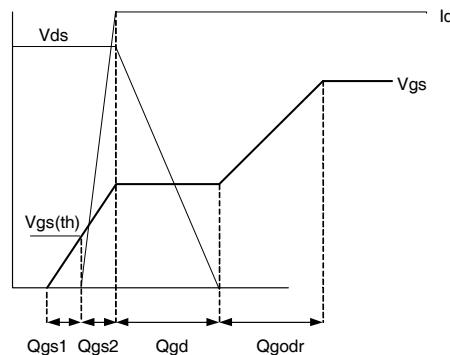
**Fig 19a.** Unclamped Inductive Test Circuit



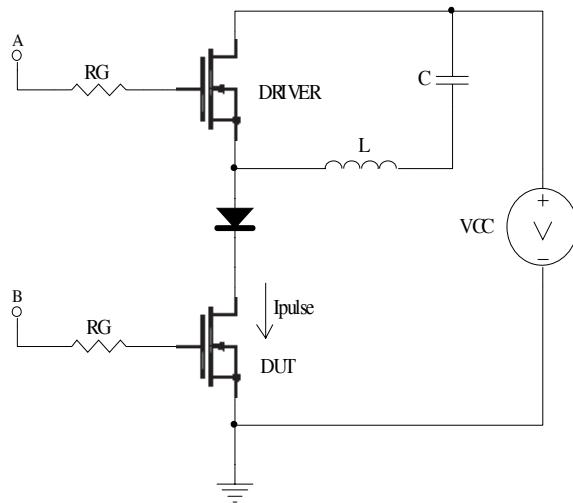
**Fig 19b.** Unclamped Inductive Waveforms



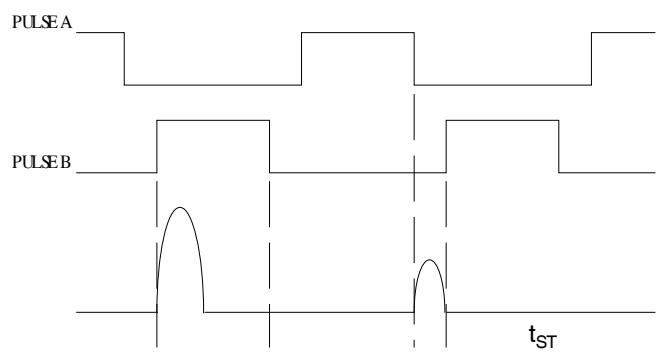
**Fig 20a.** Gate Charge Test Circuit



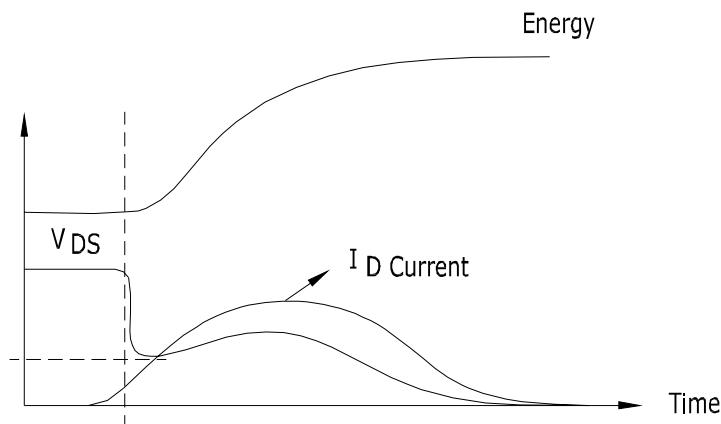
**Fig 20b.** Gate Charge Waveform



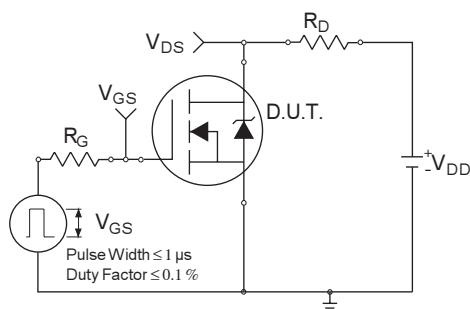
**Fig 21a.**  $t_{st}$  and  $E_{PULSE}$  Test Circuit



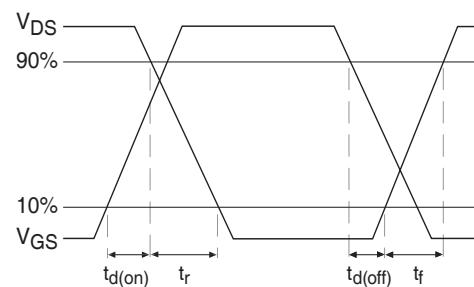
**Fig 21b.**  $t_{st}$  Test Waveforms



**Fig 21c.**  $E_{PULSE}$  Test Waveforms



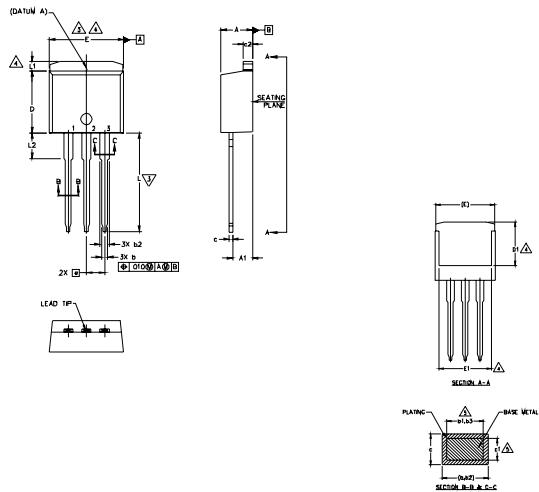
**Fig 22a.** Switching Time Test Circuit



**Fig 22b.** Switching Time Waveforms

## TO-262 Package Outline

Dimensions are shown in millimeters (inches)



**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 (.005") PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
6. CONTROLLING DIMENSION: INCH.
7. OUTLINE CONFORMS TO JEDEC TO-262 EXCEPT A1(max.), b1(min.) AND D1(min.) WHERE DIMENSIONS DERIVED ACTUAL PACKAGE OUTLINE.

S O L	DIMENSIONS		N T E S	
	MILLIMETERS	INCHES		
	MN.	MAX.	MN.	MAX.
A	4.06	4.83	.160	.190
A1	2.03	3.02	.080	.119
b	0.61	0.99	.020	.039
b1	0.61	0.89	.030	.036
b2	1.14	1.78	.045	.070
b3	1.14	1.73	.045	.068
c	0.38	0.74	.015	.029
c1	0.38	0.58	.015	.023
c2	1.14	1.65	.045	.065
D	8.38	9.65	.330	.360
D1	6.86	—	.270	.4
E	9.65	10.67	.380	.420
E1	6.22	—	.245	.4
•	2.54	BSC	.100	BSC
L	13.46	14.10	.530	.565
L1	—	1.65	—	.065
L2	3.56	3.71	.140	.146

### LEAD ASSIGNMENTS

**HEXFET**

1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

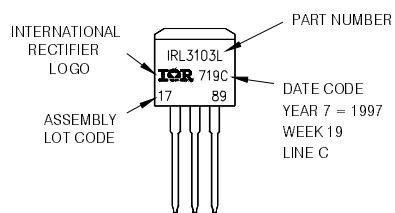
**IGBTs, CoolPACK**

1. GATE
2. COLLECTOR
3. Emitter
4. COLLECTOR

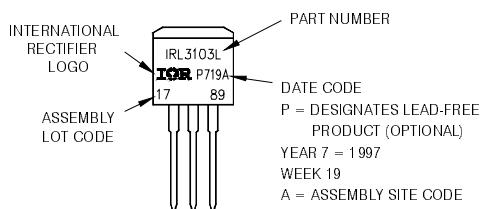
## TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L  
LOT CODE 1789  
ASSEMBLED ON WW 19, 1997  
IN THE ASSEMBLY LINE 'C'

Note: "P" in assembly line position  
indicates "Lead - Free"



OR



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.37\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 26\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④  $R_\theta$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .
- ⑤ Half sine wave with duty cycle = 0.25,  $t_{on}=1\mu\text{sec}$ .

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Industrial market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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